

Search Notes

Application/Control No.

10/076,256

Examiner

David E. Bochna

Applicant(s)/Patent under
Reexamination

PELFREY ET AL.

Art Unit

3679

SEARCHED

Class	Subclass	Date	Examiner
285	72	11/10/2005	DB
	79,312		
	124.3,116		
	124.4,26		
	124.5,71		
	124.1,87		
	124.2		
	83		
	82		
	311		
29	890.14		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
285	124.3-5	11/10/2005	DB
	79,82,311		
	71		

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR